

Wuxi Unigroup Microelectronics CO.,LTD.

40V N-Channel Trench MOSFET(Preliminary)

General Description	General Description		Product Summary		
 Trench Power technology Low R_{DS(ON)} Low Gate Charge Optimized for fast-switching 	rench Power technology Low R _{DS(ON)}		V_{DS} $I_{D} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 10V)$ $R_{DS(ON)} (at V_{GS} = 4.5V)$	40V 100A < 4.5mΩ < 7.0mΩ	
 Applications Synchronous Rectification ir Isolated DC/DC Converters i 			100% UIS Tested	RoHS	
	TO-220	7	G G S		
Part Number		де Туре	Form	Marking	
TTP100N04AT	то	-220	Tube	100N04AT	
	tings (T _A =2	5ºC unless o Symbol	therwise noted) Maximum	Units	
Parameter	tings (T _A =2	1		Units V	
Parameter Drain-Source Voltage	tings (T _A =2	Symbol	Maximum		
Parameter Drain-Source Voltage Gate-Source Voltage	T _c =25°C	Symbol V _{DS}	Maximum 40	V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current ^B		Symbol V _{DS} V _{GS}	Maximum 40 ±20 100	V V	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current	T _c =25°C	Symbol V _{DS} V _{GS} I _D	Maximum 40 ±20 100 67	V V A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current	T _c =25°C	Symbol V _{DS} V _{GS} I _D I _{DM}	Maximum 40 ±20 100 67 300	V V A A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy	T _c =25°C T _c =100°C	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS}	Maximum 40 ±20 100 67 300 24	V V A A A A	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy	T _c =25°C T _c =100°C L =0.3mH ^A	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS}	Maximum 40 ±20 100 67 300 24 86	V V A A A M MJ	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy Power Dissipation C	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS}	Maximum 40 ±20 100 67 300 24 86 127	V V A A A M M W	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy Power Dissipation C Junction and Storage Temperatu	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D	Maximum 40 ±20 100 67 300 24 86 127 78	V V A A A M M W W	
Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy Power Dissipation C Junction and Storage Temperatu Thermal Characteristics	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D	Maximum 40 ±20 100 67 300 24 86 127 78	V V A A A M M W W	
Absolute Maximum Ra Parameter Drain-Source Voltage Gate-Source Voltage Continuous Drain Current B Pulsed Drain Current Avalanche Current A Single Pulse Avalanche Energy Power Dissipation C Junction and Storage Temperatu Thermal Characteristics Parameter Maximum Junction-to-Case	$T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$ $L = 0.3mH^{A}$ $T_{c} = 25^{\circ}C$ $T_{c} = 100^{\circ}C$	Symbol V _{DS} V _{GS} I _D I _{DM} I _{AS} E _{AS} P _D T _J , T _{STG}	Maximum 40 ±20 100 67 300 24 86 127 78 -55 to 175	V V A A A M M W W W W	



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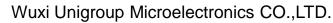
Electric	cal Characteristics(T _J =25°C ur	less otherwise	noted)				
0		rameter Conditions		Value			
Symbol	Parameter			Min	Тур	Max	Units
STATIC P	ARAMETERS				-	-	
BV_{DSS}	Drain-Source Breakdown Voltage	$I_{D} = 250 \mu A, V_{GS} = 0 V$		40			V
		V _{DS} =40V, V _{GS} =0V	T _J =25°C			1	μA
I _{DSS}	Zero Gate Voltage Drain Current		T _J =100°C			25	
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$				±100	nA
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = 250 \mu A$		1	1.7	2.4	V
D	Static Drain-Source On-Resistance	V _{GS} =10V, I _D =30A			3.6	4.5	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =4.5V, I _D =30A			5.3	7	mΩ
9 _{FS}	Forward Transconductance	V _{DS} =10V, I _D =20A			22.1		S
V_{SD}	Diode Forward Voltage	I _S =30A, V _{GS} =0V				1	V
I _s	Maximum Body-Diode Continuous Curre	rrent ^B				100	А
DYNAMIC	PARAMETERS				-	-	
C _{iss}	Input Capacitance	V _{GS} =0V, V _{DS} =20V, f =1MH _Z			4484		pF
C _{oss}	Output Capacitance				831		
C _{rss}	Reverse Transfer Capacitance				386		
SWITCHI	NG PARAMETERS					-	
Q _g (10V)	Total Gate Charge	V _{GS} =10V,V _{DS} =20V, I _D =50A			80		
Q_{gs}	Gate Source Charge				14		nC
Q_{gd}	Gate Drain Charge				14		
t _{D(on)}	Turn-On Delay Time	$V_{GS} = 10V, V_{DS} = 20V, I_{D} = 50A,$ $R_{G} = 3\Omega$			16		- ns
t _r	Turn-On Rise Time				18		
T _{D(off)}	Turn-Off Delay Time				50		
t _f	Turn-Off Fall Time				22		
t _{rr}	Body Diode Reverse Recovery Time				40		ns
Q _{rr}	Body Diode Reverse Recovery Charge	— I _F =20A, di/dt =100A/μs e			44		nC

A. Single pulse width limited by maximum junction temperature.

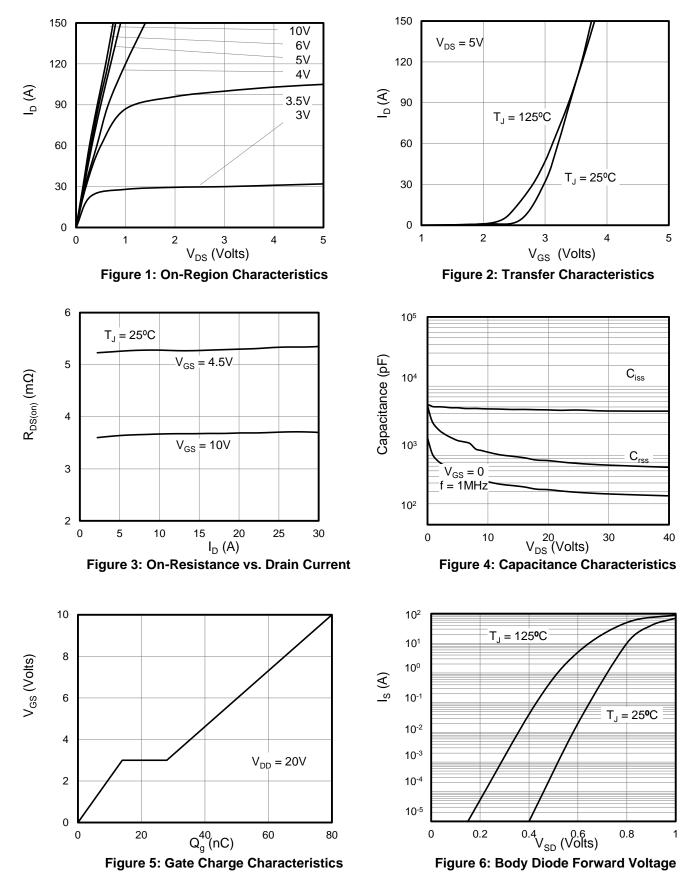
B. The maximum current rating is package limited.

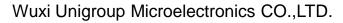
C. The power dissipation P_D is based on $T_{J(MAX)} = 175^{\circ}$ C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

TTP100N04AT



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS





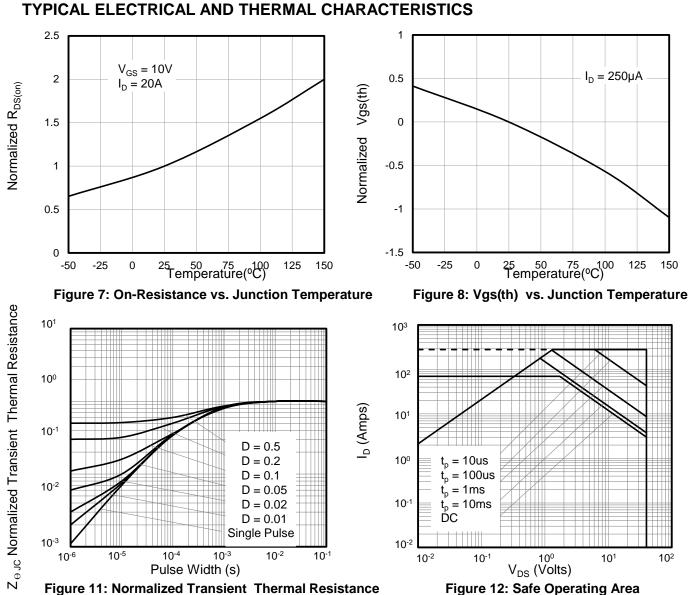


Figure 11: Normalized Transient Thermal Resistance

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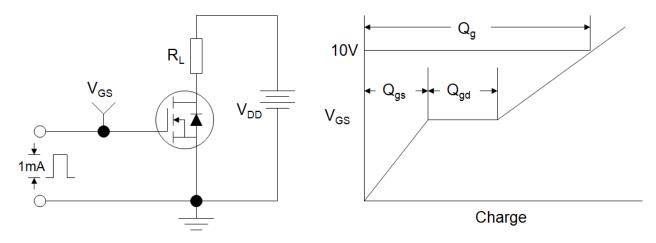


Figure A: Gate Charge Test Circuit and Waveforms

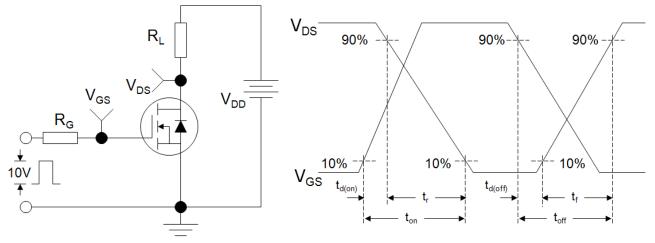


Figure B: Resistive Switching Test Circuit and Waveforms

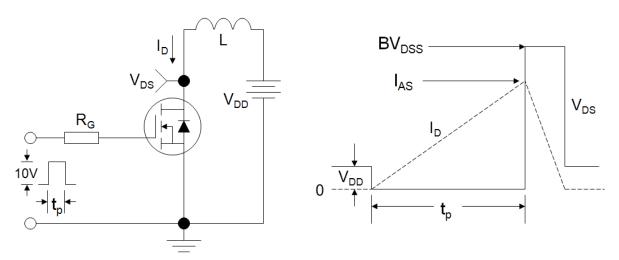
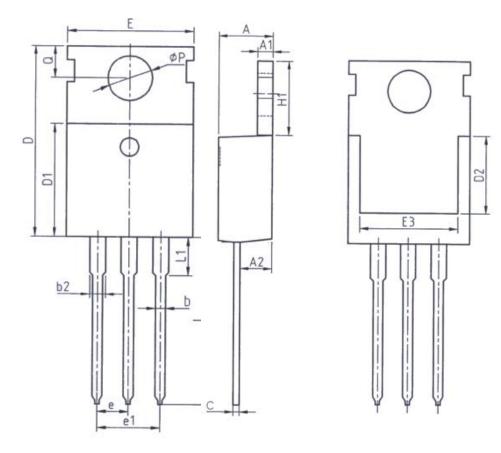


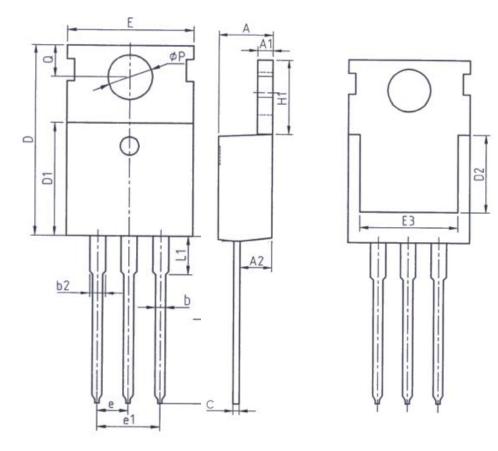
Figure C: Unclamped Inductive Switching (UIS) Test Circuit and Waveforms



Unit: mm			
Symbol	Min.	Max.	
Α	4.37	4.77	
A1	1.25	1.45	
A2	2. 20	2.60	
b	0.70	0.95	
b2	1.17	1.47	
С	0.40	0.65	
D	15.10	16. 10	
D1	8.80	9.40	
D2	5.50	-	

Unit: mm			
Symbol	Min.	Max.	
E	9.70	10. 30	
E3	7.00	-	
e	2.54BSC		
e1	5. 08BSC		
H1	6. 25	6.85	
L	12.75	13.80	
L1	I	3. 40	
Р	3. 40	3.80	
Q	2.60	3.00	

E



Unit: mm			
Symbol	Min.	Max.	
Α	4.37	4.77	
A1	1.25	1.45	
A2	2. 20	2.60	
b	0.70	0.95	
b2	1.17	1.47	
С	0.40	0.65	
D	15.10	16. 10	
D1	8.80	9.40	
D2	5.50	-	

Unit: mm			
Symbol	Min.	Max.	
E	9.70	10. 30	
E3	7.00	-	
e	2.54BSC		
e1	5. 08BSC		
H1	6. 25	6.85	
L	12.75	13.80	
L1	-	3.40	
Р	3. 40	3.80	
Q	2.60	3.00	

t



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